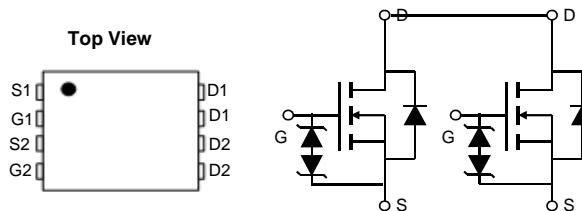


General Description

The AON7820 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{SS(ON)}$. This device is ideal for load switch and battery protection applications.

Features

| | |
|----------------------------------|--------|
| V_{DS} | 20V |
| I_S (at $V_{GS}=4.5V$) | 35A |
| $R_{SS(ON)}$ (at $V_{GS}=4.5V$) | < 16mΩ |
| $R_{SS(ON)}$ (at $V_{GS}=3.5V$) | < 17mΩ |
| $R_{SS(ON)}$ (at $V_{GS}=2.5V$) | < 20mΩ |



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | 20 | V |
| Gate-Source Voltage | V_{GS} | ± 12 | V |
| Continuous Drain Current $T_C=25^\circ\text{C}$ | I_S | 35 | A |
| $T_C=100^\circ\text{C}$ | I_S | 22 | |
| Pulsed Drain Current ^C | I_{SM} | 80 | |
| Continuous Drain Current $T_A=25^\circ\text{C}$ | I_{SSM} | 11 | A |
| $T_A=70^\circ\text{C}$ | I_{SSM} | 9 | |
| Power Dissipation ^B $T_C=25^\circ\text{C}$ | P_D | 31 | W |
| $T_C=100^\circ\text{C}$ | P_D | 12.5 | |
| Power Dissipation ^A $T_A=25^\circ\text{C}$ | P_{DSM} | 3.1 | W |
| $T_A=70^\circ\text{C}$ | P_{DSM} | 2 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|---|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient ^A $t \leq 10\text{s}$ | $R_{\theta JA}$ | 30 | 40 | °C/W |
| Maximum Junction-to-Ambient ^{A,D} Steady-State | | 60 | 75 | °C/W |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 3.2 | 4 | °C/W |



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飞思卡尔(深圳)功率半导体有限公司

AON7820
20V Dual N-Channel MOSFET

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

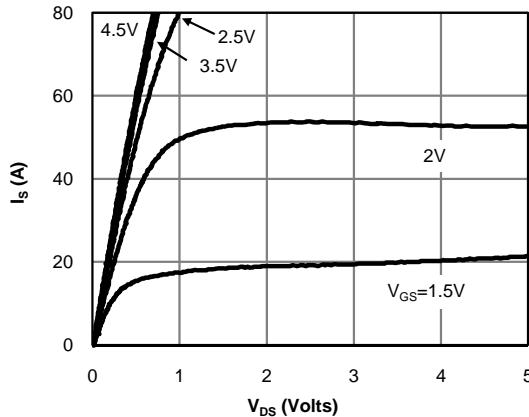


Fig 1: On-Region Characteristics (Note E)

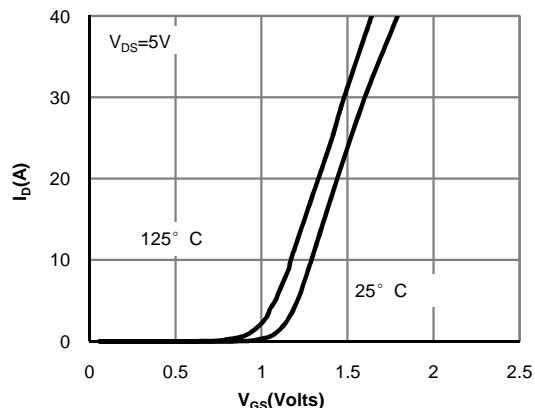


Figure 2: Transfer Characteristics (Note E)

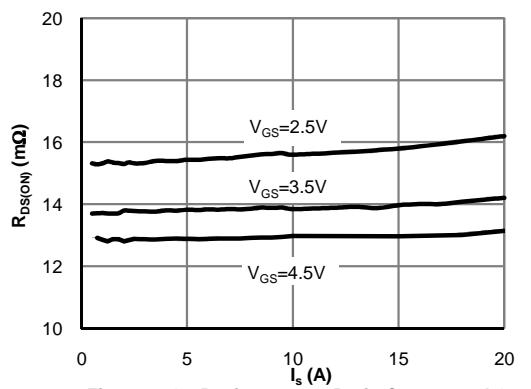


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

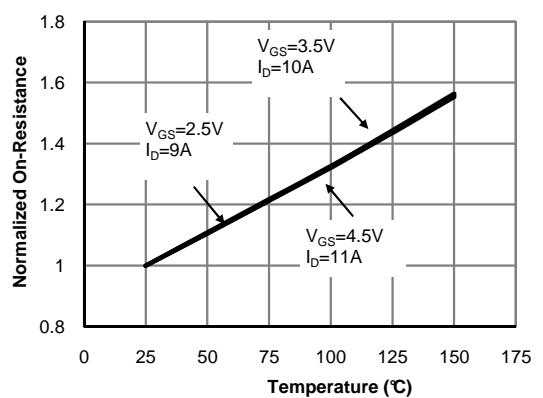


Figure 4: On-Resistance vs. Junction Temperature (Note E)

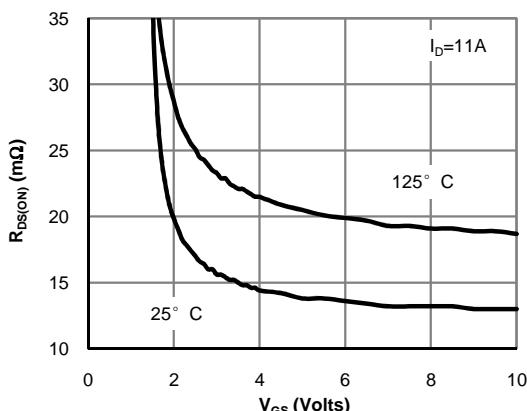


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

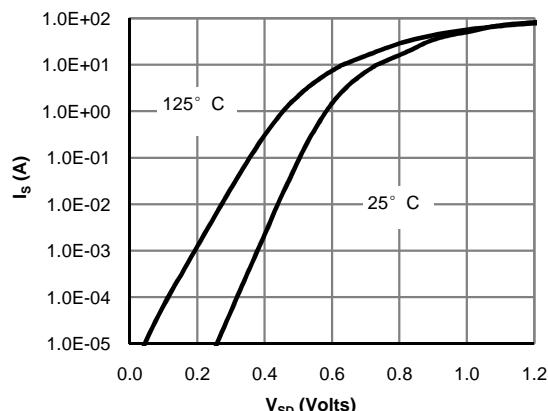


Figure 6: Body-Diode Characteristics (Note E)

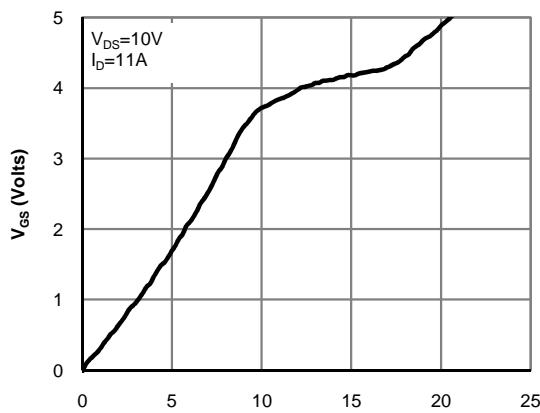
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Figure 7: Gate-Charge Characteristics

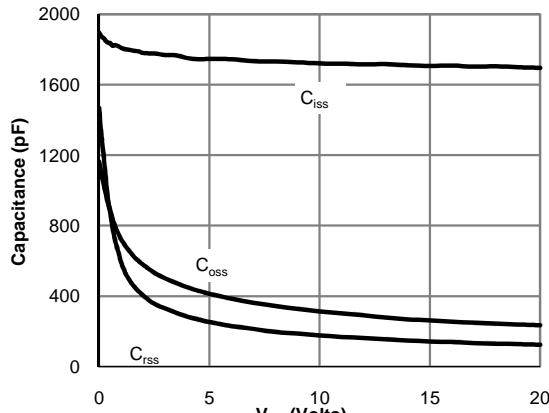


Figure 8: Capacitance Characteristics

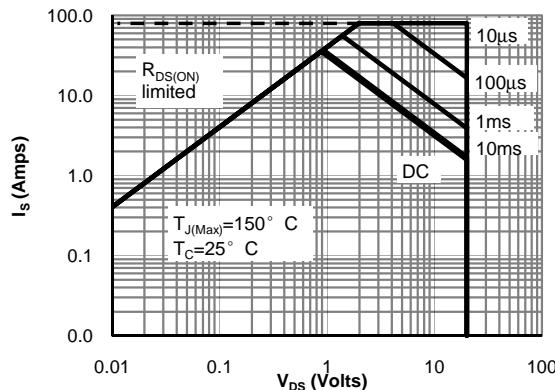


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

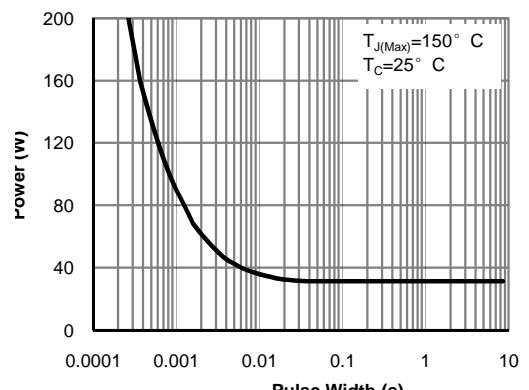


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

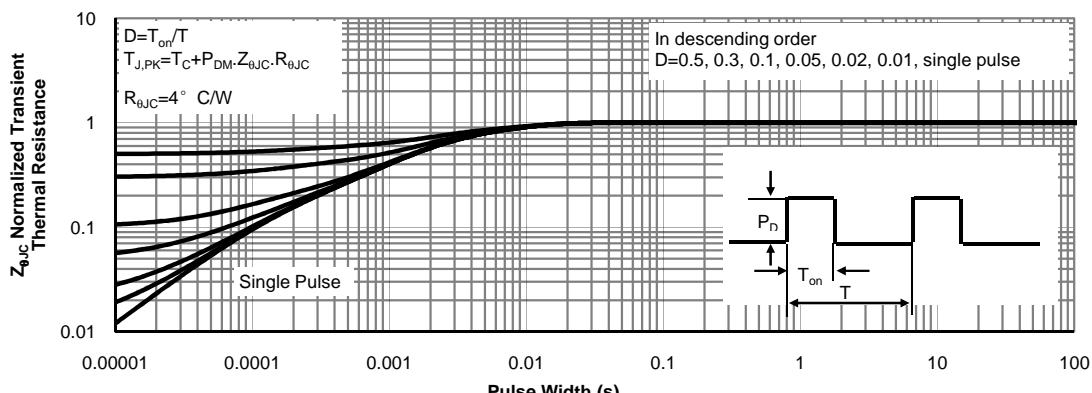


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

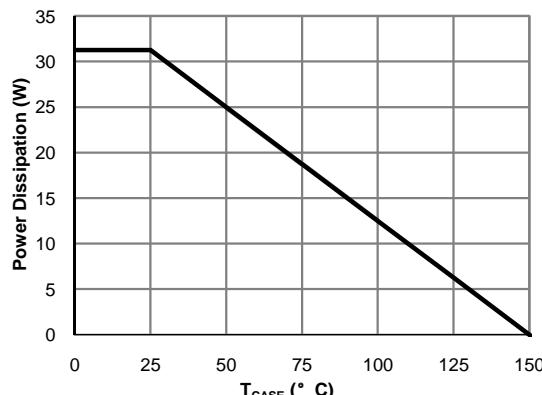
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Figure 12: Power De-rating (Note F)

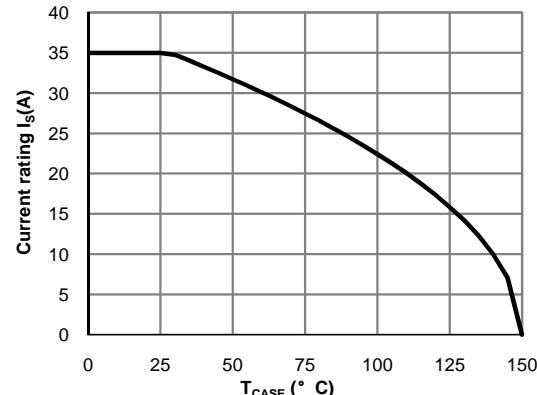


Figure 13: Current De-rating (Note F)

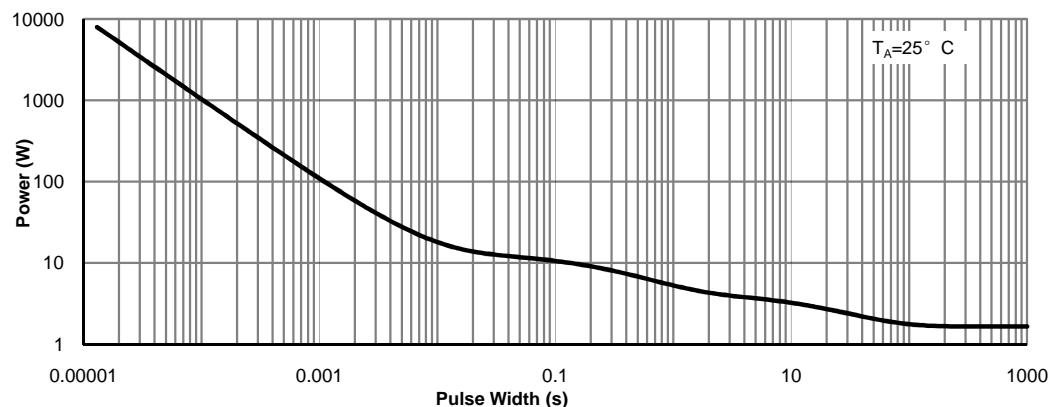


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

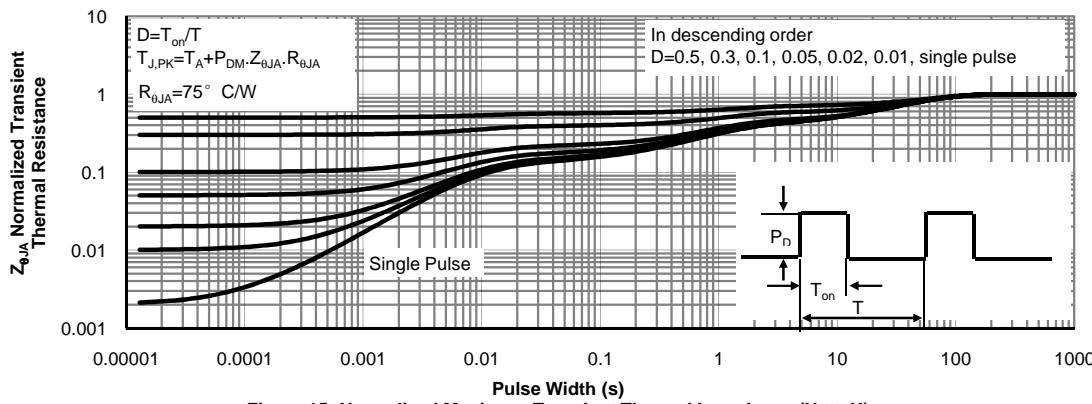
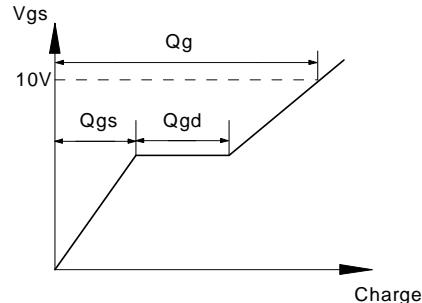
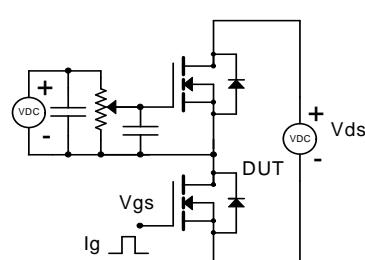
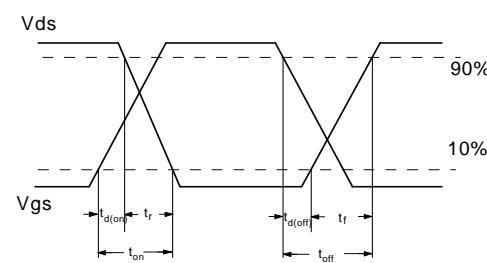
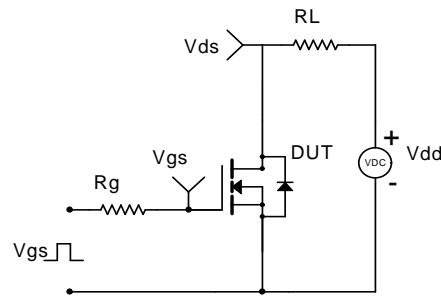


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

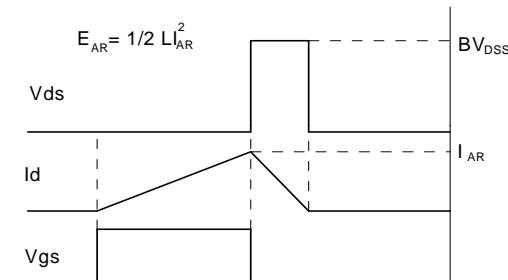
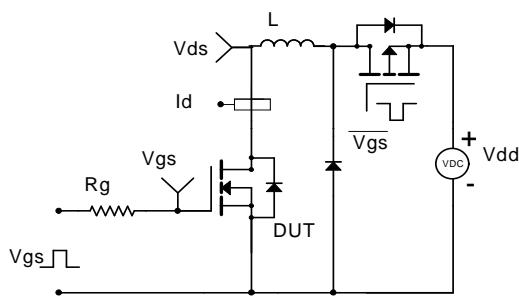
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

